

PRERELEASE
Electrical Specifications Subject to Change
LTC2175-14/

LTC2174-14/LTC2173-14

14-Bit, 125Msps/105Msps/ 80Msps Low Power Quad ADCs

FEATURES

- 4-Channel Simultaneous Sampling ADC
- 73.4dB SNR
- 88dB SFDR
- Low Power: 558mW/450mW/376mW
- Single 1.8V Supply
- Serial LVDS Outputs: 1 or 2 Bits per Channel
- Selectable Input Ranges: 1V_{P-P} to 2V_{P-P}
- 800MHz Full Power Bandwidth S/H
- Shutdown and Nap Modes
- Serial SPI Port for Configuration
- Pin Compatible 14-Bit and 12-Bit Versions
- 52-Pin (7mm × 8mm) QFN Package

APPLICATIONS

- Communications
- Cellular Base Stations
- Software Defined Radios
- Portable Medical Imaging
- Multichannel Data Acquisition
- Nondestructive Testing

∠7, LT, LTC, LTM, Linear Technology and the Linear logo are registered trademarks of Linear Technology Corporation. All other trademarks are the property of their respective owners.

DESCRIPTION

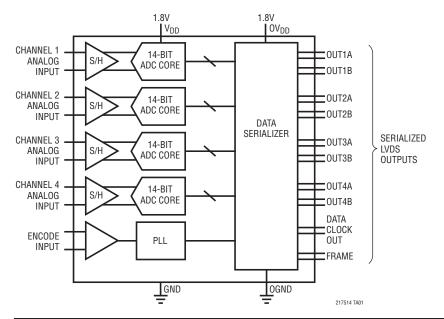
The LTC®2175-14/2174-14/2173-14 are 4-channel, simultaneous sampling 14-bit A/D converters designed for digitizing high frequency, wide dynamic range signals. They are perfect for demanding communications applications with AC performance that includes 73.4dB SNR and 88dB spurious free dynamic range (SFDR). Ultralow jitter of 0.15ps_{RMS} allows undersampling of IF frequencies with excellent noise performance.

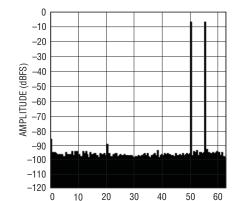
DC specs include ± 1 LSB INL (typ), ± 0.3 LSB DNL (typ) and no missing codes over temperature. The transition noise is a low 1.2 LSB_{RMS}.

The digital outputs are serial LVDS to minimize the number of data lines. Each channel outputs two bits at a time (2-lane mode). At lower sampling rates there is a one bit per channel option (1-lane mode). The LVDS drivers have optional internal termination and adjustable output levels to ensure clean signal integrity.

The ENC⁺ and ENC⁻ inputs may be driven differentially or single-ended with a sine wave, PECL, LVDS, TTL, or CMOS inputs. An internal clock duty cycle stabilizer allows high performance at full speed for a wide range of clock duty cycles.

TYPICAL APPLICATION





FREQUENCY (MHz)

LTC2175-14, 125Msps,

2-Tone FFT, $f_{IN} = 70MHz$ and 75MHz

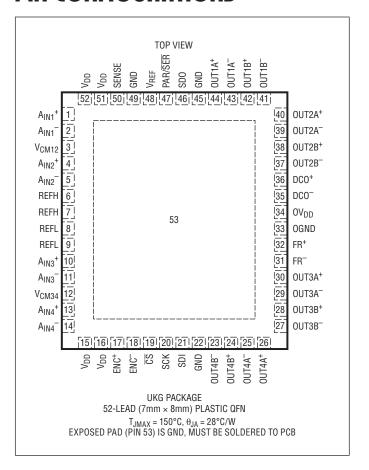
21754314p

217514 TA01b



ABSOLUTE MAXIMUM RATINGS

PIN CONFIGURATIONS



ORDER INFORMATION

| LEAD FREE FINISH | TAPE AND REEL | PART MARKING* | PACKAGE DESCRIPTION | TEMPERATURE RANGE |
|--------------------|----------------------|---------------|---------------------------------|-------------------|
| LTC2175CUKG-14#PBF | LTC2175CUKG-14#TRPBF | LTC2175UKG-14 | 52-Lead (7mm × 8mm) Plastic QFN | 0°C to 70°C |
| LTC2175IUKG-14#PBF | LTC2175IUKG-14#TRPBF | LTC2175UKG-14 | 52-Lead (7mm × 8mm) Plastic QFN | -40°C to 85°C |
| LTC2174CUKG-14#PBF | LTC2174CUKG-14#TRPBF | LTC2174UKG-14 | 52-Lead (7mm × 8mm) Plastic QFN | 0°C to 70°C |
| LTC2174IUKG-14#PBF | LTC2174IUKG-14#TRPBF | LTC2174UKG-14 | 52-Lead (7mm × 8mm) Plastic QFN | -40°C to 85°C |
| LTC2173CUKG-14#PBF | LTC2173CUKG-14#TRPBF | LTC2173UKG-14 | 52-Lead (7mm × 8mm) Plastic QFN | 0°C to 70°C |
| LTC2173IUKG-14#PBF | LTC2173IUKG-14#TRPBF | LTC2173UKG-14 | 52-Lead (7mm × 8mm) Plastic QFN | -40°C to 85°C |

Consult LTC Marketing for parts specified with wider operating temperature ranges. *The temperature grade is identified by a label on the shipping container. Consult LTC Marketing for information on non-standard lead based finish parts.

For more information on lead free part marking, go to: http://www.linear.com/leadfree/ For more information on tape and reel specifications, go to: http://www.linear.com/tapeandreel/



CONVERTER CHARACTERISTICS The \bullet denotes the specifications which apply over the full operating temperature range, otherwise specifications are at $T_A = 25 \,^{\circ}\text{C}$. (Note 5)

| | | | LT | C2175- | 14 | LT | C2174- | 14 | LT | C2173-1 | 14 | |
|-------------------------------|------------------------------------------|---|-------|--------------|------|-------|--------------|------|------|--------------|-----|--------------------|
| PARAMETER | CONDITIONS | | MIN | TYP | MAX | MIN | TYP | MAX | MIN | TYP | MAX | UNITS |
| Resolution (No Missing Codes) | | • | 14 | | | 14 | | | 14 | | | Bits |
| Integral Linearity Error | Differential Analog Input (Note 6) | • | -3.75 | ±1 | 3.75 | -3.75 | ±1 | 3.75 | -3.5 | ±1 | 3.5 | LSB |
| Differential Linearity Error | Differential Analog Input | • | -0.9 | ±0.3 | 0.9 | -0.9 | ±0.3 | 0.9 | -0.9 | ±0.3 | 0.9 | LSB |
| Offset Error | (Note 7) | • | -15 | ±3 | 15 | -15 | ±3 | 15 | -15 | ±3 | 15 | mV |
| Gain Error | Internal Reference External Reference | • | -1.5 | ±1.5 ±0.4 | 1.5 | -1.5 | ±1.5 ±0.4 | 1.5 | -1.5 | ±1.5 ±0.4 | 1.5 | %FS %FS |
| Offset Drift | | | | ±20 | | | ±20 | | | ±20 | | μV/°C |
| Full-Scale Drift | Internal Reference External Reference | | | ±35 ±25 | | | ±35 ±25 | | | ±35 ±25 | | ppm/°C ppm/°C |
| Gain Matching | External Reference | | | ±0.2 | | | ±0.2 | | | ±0.2 | | %FS |
| Offset Matching | | | | ±3 | | | ±3 | | | ±3 | | mV |
| Transition Noise | External Reference | | | 1.2 | | | 1.2 | | | 1.2 | | LSB _{RMS} |

RNALOG INPUT The \bullet denotes the specifications which apply over the full operating temperature range, otherwise specifications are at $T_A = 25^{\circ}C$. (Note 5)

| SYMBOL | PARAMETER | CONDITIONS | | MIN | TYP | MAX | UNITS |
|---------------------|-------------------------------------------------------------------------------------------|---------------------------------------------------------|---|-------------------------|-------------------|-------------------------|-------------------|
| V _{IN} | Analog Input Range (A _{IN} ⁺ – A _{IN} ⁻) | 1.7V < V _{DD} < 1.9V | • | | 1 to 2 | | V _{P-P} |
| V _{IN(CM)} | Analog Input Common Mode (A _{IN} ⁺ + A _{IN} ⁻)/2 | Differential Analog Input (Note 8) | • | V _{CM} – 100mV | V _{CM} | V _{CM} + 100mV | V |
| V _{SENSE} | External Voltage Reference Applied to SENSE | External Reference Mode | • | 0.625 | 1.250 | 1.300 | V |
| I _{INCM} | Analog Input Common Mode Current | Per Pin, 125Msps Per Pin, 105Msps Per Pin, 80Msps | | | 155 130 100 | | μΑ μΑ μΑ |
| I _{IN1} | Analog Input Leakage Current No Encode | $0 < A_{IN}^+, A_{IN}^- < V_{DD},$ | • | -1 | | 1 | μA |
| I _{IN2} | PAR/SER Input Leakage Current | 0 < PAR/SER < V _{DD} | • | -3 | | 3 | μΑ |
| I _{IN3} | SENSE Input Leakage Current | 0.625 < SENSE < 1.3V | • | -6 | | 6 | μA |
| t _{AP} | Sample-and-Hold Acquisition Delay Time | | | | 0 | | ns |
| t _{JIπer} | Sample-and-Hold Acquisition Delay Jitter | | | | 0.15 | | ps _{RMS} |
| CMRR | Analog Input Common Mode Rejection Ratio | | | | 80 | | dB |
| BW-3B | Full-Power Bandwidth | Figure 6 Test Circuit | | | 800 | | MHz |

DYNAMIC ACCURACY The \bullet denotes the specifications which apply over the full operating temperature range, otherwise specifications are at $T_A = 25^{\circ}C$. $A_{IN} = -1 dBFS$. (Note 5)

| | | | | Lī | C2175- | 14 | LI | C2174- | 14 | LT | C2173-1 | 14 | |
|---------|-------------------------------------------------------|-------------------------------------------|---|------|----------------------|-----|------|----------------------|-----|------|----------------------|-----|----------------------|
| SYMBOL | PARAMETER | CONDITIONS | | MIN | TYP | MAX | MIN | TYP | MAX | MIN | TYP | MAX | UNITS |
| SNR | Signal-to-Noise Ratio | 5MHz Input 70MHz Input 140MHz Input | • | 71.3 | 73.4 73.2 72.7 | | 71.3 | 73.4 73.2 72.7 | | 70.9 | 73.1 72.9 72.4 | | dBFS dBFS dBFS |
| SFDR | Spurious Free Dynamic Range 2nd or 3rd Harmonic | 5MHz Input 70MHz Input 140MHz Input | • | 76 | 88 85 82 | | 76 | 88 85 82 | | 79 | 88 85 82 | | dBFS dBFS dBFS |
| | Spurious Free Dynamic Range 4th Harmonic or Higher | 5MHz Input 70MHz Input 140MHz Input | • | 85 | 90 90 90 | | 83 | 90 90 90 | | 85 | 90 90 90 | | dBFS dBFS dBFS |
| S/(N+D) | Signal-to-Noise Plus Distortion Ratio | 5MHz Input 70MHz Input 140MHz Input | • | 70.2 | 73 72.6 72 | | 70.2 | 73 72.6 72 | | 70.4 | 72.9 72.6 72 | | dBFS dBFS dBFS |
| | Crosstalk, Near Channel | 10MHz Input (Note 12) | | | -90 | | | -90 | | | -90 | | dBc |
| | Crosstalk, Far Channel | 10MHz Input (Note 12) | | | -105 | | | -105 | | | -105 | | dBc |

INTERNAL REFERENCE CHARACTERISTICS The ullet denotes the specifications which apply over the full operating temperature range, otherwise specifications are at $T_A=25^{\circ}C$. $A_{IN}=-1dBFS$. (Note 5)

| PARAMETER | CONDITIONS | MIN | TYP | MAX | UNITS |
|-------------------------------------------|---------------------------------|------------------------------|-----------------------|------------------------------|--------|
| V _{CM} Output Voltage | I _{OUT} = 0 | 0.5 • V _{DD} − 25mV | 0.5 • V _{DD} | 0.5 • V _{DD} + 25mV | V |
| V _{CM} Output Temperature Drift | | | ±25 | | ppm/°C |
| V _{CM} Output Resistance | -600μA < I _{OUT} < 1mA | | 4 | | Ω |
| V _{REF} Output Voltage | I _{OUT} = 0 | 1.225 | 1.250 | 1.275 | V |
| V _{REF} Output Temperature Drift | | | ±25 | | ppm/°C |
| V _{REF} Output Resistance | -400μA < I _{OUT} < 1mA | | 7 | | Ω |
| V _{REF} Line Regulation | 1.7V < V _{DD} < 1.9V | | 0.6 | | mV/V |

DIGITAL INPUTS AND OUTPUTS The \bullet denotes the specifications which apply over the full operating temperature range, otherwise specifications are at $T_A = 25$ °C. (Note 5)

| SYMBOL | PARAMETER | CONDITIONS | | MIN | ТҮР | MAX | UNITS |
|---------------------|---------------------------------------------------|--------------------------------------------------------------------------------------|----------|----------------|----------------|----------------|----------|
| ENCODE | NPUTS (ENC+, ENC-) | | | | | | |
| Differenti | al Encode Mode (ENC ⁻ Not Tied to GND) | | | | | | |
| $\overline{V_{ID}}$ | Differential Input Voltage | (Note 8) | • | 0.2 | | | V |
| V _{ICM} | Common Mode Input Voltage | Internally Set Externally Set (Note 8) | • | 1.1 | 1.2 | 1.6 | V |
| V _{IN} | Input Voltage Range | ENC+, ENC- to GND | • | 0.2 | | 3.6 | V |
| R _{IN} | Input Resistance | (See Figure 10) | | | 10 | | kΩ |
| C _{IN} | Input Capacitance | | | | 3.5 | | pF |
| Single-En | ded Encode Mode (ENC ⁻ Tied to GND) | | ' | | | | |
| $\overline{V_{IH}}$ | High Level Input Voltage | V _{DD} = 1.8V | • | 1.2 | | | V |
| V_{IL} | Low Level Input Voltage | V _{DD} = 1.8V | • | | | 0.6 | V |
| V _{IN} | Input Voltage Range | ENC+ to GND | • | 0 | | 3.6 | V |
| R _{IN} | Input Resistance | (See Figure 11) | | | 30 | | kΩ |
| C _{IN} | Input Capacitance | | | | 3.5 | | pF |
| DIGITAL I | NPUTS (CS, SDI, SCK in Serial or Paralle | l Programming Mode. SDO in Parallel Progra | amming | y Mode) | | | |
| V_{IH} | High Level Input Voltage | V _{DD} = 1.8V | • | 1.3 | | | V |
| V_{IL} | Low Level Input Voltage | V _{DD} = 1.8V | • | | | 0.6 | V |
| I _{IN} | Input Current | V _{IN} = 0V to 3.6V | • | -10 | | 10 | μА |
| C _{IN} | Input Capacitance | | | | 3 | | pF |
| SDO OUT | PUT (Serial Programming Mode. Open-Di | ain Output. Requires 2kΩ Pull-Up Resistor i | f SDO is | s Used) | | | |
| R _{OL} | Logic Low Output Resistance to GND | V _{DD} = 1.8V, SDO = 0V | | | 200 | | Ω |
| I _{OH} | Logic High Output Leakage Current | SD0 = 0V to 3.6V | • | -10 | | 10 | μА |
| C _{OUT} | Output Capacitance | | | | 3 | | pF |
| DIGITAL I | DATA OUTPUTS | | • | | | | |
| V_{OD} | Differential Output Voltage | 100Ω Differential Load, 3.5mA Mode 100Ω Differential Load, 1.75mA Mode | | 247 125 | 350 175 | 454 250 | mV mV |
| V _{0S} | Common Mode Output Voltage | 100Ω Differential Load, 3.5mA Mode 100Ω Differential Load, 1.75mA Mode | | 1.125 1.125 | 1.250 1.250 | 1.375 1.375 | V |
| R _{TERM} | On-Chip Termination Resistance | Termination Enabled, OV _{DD} = 1.8V | | | 100 | | Ω |



POWER REQUIREMENTS The \bullet denotes the specifications which apply over the full operating temperature range, otherwise specifications are at $T_A = 25 \, ^{\circ}\text{C}$. (Note 9)

| | | | | | C2175- | 14 | LTC2174-14 | | | LTC2173-14 | | | |
|----------------------|------------------------------------------------------|-----------------------------------------------------|---|-----|------------|------------|------------|------------|------------|------------|------------|------------|----------|
| SYMBOL | PARAMETER | CONDITIONS | | MIN | TYP | MAX | MIN | TYP | MAX | MIN | TYP | MAX | UNITS |
| V_{DD} | Analog Supply Voltage | (Note 10) | • | 1.7 | 1.8 | 1.9 | 1.7 | 1.8 | 1.9 | 1.7 | 1.8 | 1.9 | V |
| OV _{DD} | Output Supply Voltage | (Note 10) | • | 1.7 | 1.8 | 1.9 | 1.7 | 1.8 | 1.9 | 1.7 | 1.8 | 1.9 | V |
| I _{VDD} | Analog Supply Current | Sine Wave Input | • | | 283 | TBD | | 224 | TBD | | 184 | TBD | mA |
| I _{OVDD} | Digital Supply Current | 2-Lane Mode, 1.75mA Mode 2-Lane Mode, 3.5mA Mode | • | | 27 49 | TBD TBD | | 26 48 | TBD TBD | | 25 47 | TBD TBD | mA mA |
| P _{DISS} | Power Dissipation | 2-Lane Mode, 1.75mA Mode 2-Lane Mode, 3.5mA Mode | • | | 558 598 | TBD TBD | | 450 490 | TBD TBD | | 376 416 | TBD TBD | mW mW |
| P _{SLEEP} | Sleep Mode Power | | | | 1 | | | 1 | | | 1 | | mW |
| P _{NAP} | Nap Mode Power | | | | 85 | | | 85 | | | 85 | | mW |
| P _{DIFFCLK} | Power Increase With Diff (No Increase for Sleep M | rential Encode Mode Enabled de) | | | 20 | | | 20 | | | 20 | | mW |

TIMING CHARACTERISTICS The \bullet denotes the specifications which apply over the full operating temperature range, otherwise specifications are at $T_A = 25 \,^{\circ}\text{C}$. (Note 5)

| | | | | Lī | LTC2175-14 | | LTC2174-14 | | | LTC2173-14 | | | |
|-------------------|-------------------------------------------|-------------------------------------------------------|---|----------|------------|------------|------------|--------------|------------|------------|--------------|------------|----------|
| SYMBOL | PARAMETER | CONDITIONS | | MIN | TYP | MAX | MIN | TYP | MAX | MIN | TYP | MAX | UNITS |
| f _S | Sampling Frequency | (Notes 10,11) | • | 5 | | 125 | 5 | | 105 | 5 | | 80 | MHz |
| t _{ENCL} | ENC Low Time (Note 8) | Duty Cycle Stabilizer Off Duty Cycle Stabilizer On | • | 3.8 2 | 4 4 | 100 100 | 4.52 2 | 4.76 4.76 | 100 100 | 5.93 2 | 6.25 6.25 | 100 100 | ns ns |
| t _{ENCH} | ENC High Time (Note 8) | Duty Cycle Stabilizer Off Duty Cycle Stabilizer On | • | 3.8 2 | 4 4 | 100 100 | 4.52 2 | 4.76 4.76 | 100 100 | 5.93 2 | 6.25 6.25 | 100 100 | ns ns |
| t _{AP} | Sample-and-Hold Acquisition Delay Time | | | | 0 | | | 0 | | | 0 | | ns |

| SYMBOL | PARAMETER | CONDITIONS | | MIN | TYP | MAX | UNITS |
|--------------------|------------------------------------------------|-------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|---|-----------------------------|-------------------------------------------------------------------------------------------------------------------------------------------------------------------|-----------------------------|----------------------------|
| Digital Da | ita Outputs ($R_{TERM} = 100\Omega$ Different | ial, C _L = 2pF to GND on Each Output) | | ' | | | |
| t _{SER} | Serial Data Bit Period | 2-Lanes, 16-Bit Serialization 2-Lanes, 14-Bit Serialization 2-Lanes, 12-Bit Serialization 1-Lane, 16-Bit Serialization 1-Lane, 14-Bit Serialization 1-Lane, 12-Bit Serialization | | | 1/(8 • f _S) 1/(7 • f _S) 1/(6 • f _S) 1/(16 • f _S) 1/(14 • f _S) 1/(12 • f _S) | | \$ \$ \$ \$ \$ |
| t _{FRAME} | FR to DCO Delay | (Note 8) | • | 0.35 • t _{SER} | 0.5 • t _{SER} | 0.65 • t _{SER} | S |
| t _{DATA} | DATA to DCO Delay | (Note 8) | • | 0.35 • t _{SER} | 0.5 • t _{SER} | 0.65 • t _{SER} | S |
| t _{PD} | Propagation Delay | (Note 8) | • | 0.7n + 2 • t _{SER} | 1.1n + 2 • t _{SER} | 1.5n + 2 • t _{SER} | S |
| t _R | Output Rise Time | Data, DCO, FR, 20% to 80% | | | 0.17 | | ns |
| t _F | Output Fall Time | Data, DCO, FR, 20% to 80% | | | 0.17 | | ns |
| | DCO Cycle-Cycle Jitter | t _{SER} = 1ns | | | 60 | | ps _{P-P} |
| | Pipeline Latency | | | | 6 | | Cycles |

TIMING CHARACTERISTICS The \bullet denotes the specifications which apply over the full operating temperature range, otherwise specifications are at $T_A = 25$ °C. (Note 5)

| SYMBOL | PARAMETER | CONDITIONS | | MIN | TYP | MAX | UNITS |
|------------------|--------------------------|-----------------------------------------------------------------------------------|---|-----------|-----|-----|----------|
| SPI Port T | iming (Note 8) | | | | | | |
| t _{SCK} | SCK Period | Write Mode Readback Mode, C _{SDO} = 20pF, R _{PULLUP} = 2k | • | 40 250 | | | ns ns |
| $\overline{t_S}$ | CS to SCK Setup Time | | • | 5 | | | ns |
| t_{H} | SCK to CS Setup Time | | • | 5 | | | ns |
| t_{DS} | SDI Setup Time | | • | 5 | | | ns |
| t _{DH} | SDI Hold Time | | • | 5 | | | ns |
| t _{DO} | SCK Falling to SDO Valid | Readback Mode, C _{SDO} = 20pF, R _{PULLUP} = 2k | • | | | 125 | ns |

Note 1: Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. Exposure to any Absolute Maximum Rating condition for extended periods may affect device reliability and lifetime.

Note 2: All voltage values are with respect to GND with GND and OGND shorted (unless otherwise noted).

Note 3: When these pin voltages are taken below GND or above V_{DD} , they will be clamped by internal diodes. This product can handle input currents of greater than 100mA below GND or above V_{DD} without latchup.

Note 4: When these pin voltages are taken below GND they will be clamped by internal diodes. When these pin voltages are taken above V_{DD} they will not be clamped by internal diodes. This product can handle input currents of greater than 100mA below GND without latchup.

Note 5: $V_{DD} = 0V_{DD} = 1.8V$, $f_{SAMPLE} = 125MHz$ (LTC2175), 105MHz (LTC2174), or 80MHz (LTC2173), 2-lane output mode, differential ENC+/ENC⁻ = $2V_{P-P}$ sine wave, input range = $2V_{P-P}$ with differential drive, unless otherwise noted.

Note 6: Integral nonlinearity is defined as the deviation of a code from a best fit straight line to the transfer curve. The deviation is measured from the center of the quantization band.

Note 7: Offset error is the offset voltage measured from -0.5 LSB when the output code flickers between 00 0000 0000 0000 and 11 1111 1111 1111 in 2's complement output mode.

Note 8: Guaranteed by design, not subject to test.

Note 9: $V_{DD} = 0V_{DD} = 1.8V$, $f_{SAMPLE} = 125MHz$ (LTC2175), 105MHz (LTC2174), or 80MHz (LTC2173), 2-lane output mode, ENC⁺ = single-ended 1.8V square wave, ENC⁻ = 0V, input range = $2V_{P-P}$ with differential drive, unless otherwise noted.

Note 10: Recommended operating conditions.

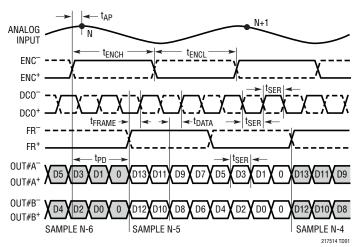
Note 11: The maximum sampling frequency depends on the speed grade of the part and also which serialization mode is used. The maximum serial data rate is 1000Mbps so t_{SER} must be greater than or equal to 1ns.

Note 12: Near-channel crosstalk refers to Ch. 1 to Ch.2, and Ch.3 to Ch.4. Far-channel crosstalk refers to Ch.1 to Ch.3, Ch.1 to Ch.4, Ch.2 to Ch.3, and Ch.2 to Ch.4.



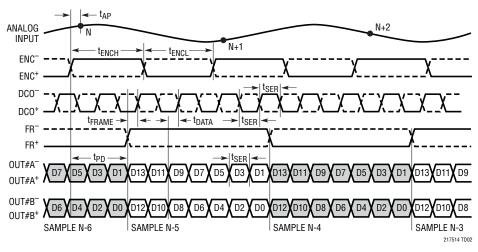
TIMING DIAGRAMS

2-Lane Output Mode, 16-Bit Serialization*



*SEE THE DIGITAL OUTPUTS SECTION

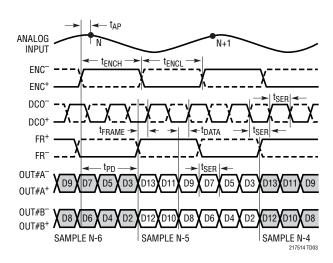
2-Lane Output Mode, 14-Bit Serialization



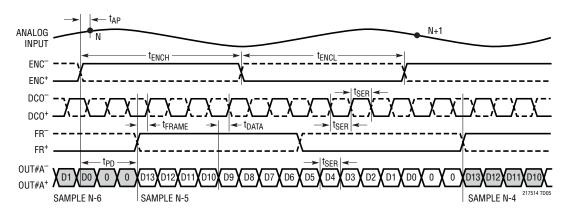
NOTE THAT IN THIS MODE FR*/FR" HAS TWO TIMES THE PERIOD OF ENC*/ENC

TIMING DIAGRAMS

2-Lane Output Mode, 12-Bit Serialization



1-Lane Output Mode, 16-Bit Serialization

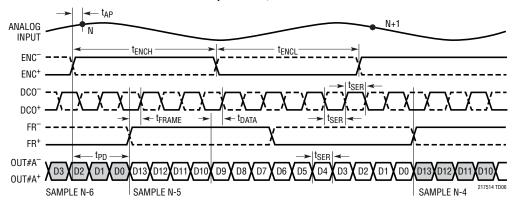


OUT#B+, OUT#B- ARE DISABLED



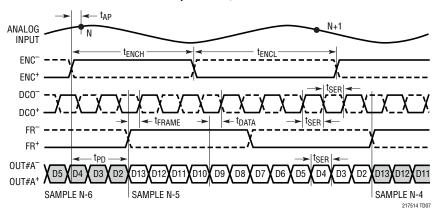
TIMING DIAGRAMS

One-Lane Output Mode, 14-Bit Serialization



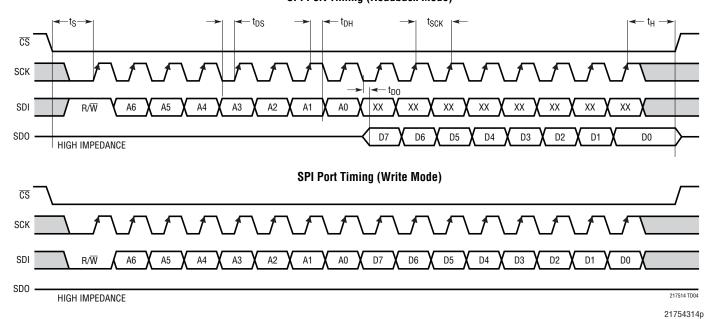
OUT#B+, OUT#B- ARE DISABLED

One-Lane Output Mode, 12-Bit Serialization

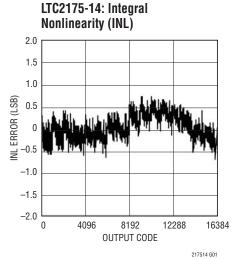


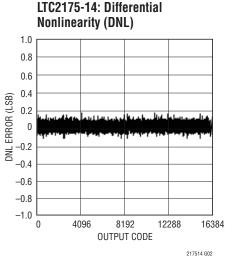
 $\mathsf{OUT\#B^+},\,\mathsf{OUT\#B^-}\,\mathsf{ARE}\,\,\mathsf{DISABLED}$

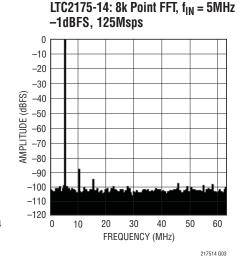
SPI Port Timing (Readback Mode)



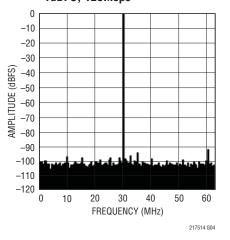




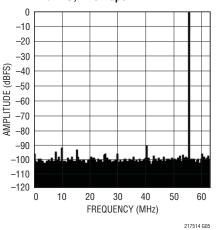




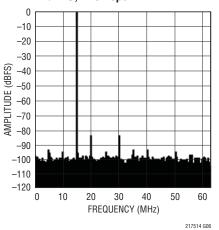
LTC2175-14: 8k Point FFT, f_{IN} = 30MHz -1dBFS, 125Msps



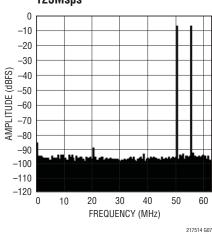
LTC2175-14: 8k Point FFT, f_{IN} = 70MHz -1dBFS, 125Msps



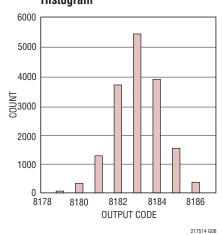
LTC2175-14: 8k Point FFT, f_{IN} = 140MHz -1dBFS, 125Msps



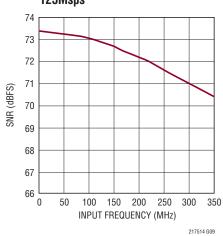
LTC2175-14: 8k Point 2-Tone FFT, $f_{\text{IN}} = 70\text{MHz}$, 75MHz, -1dBFS, 125Msps



LTC2175-14: Shorted Input Histogram

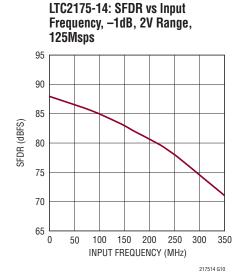


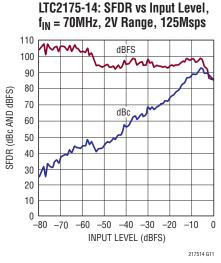
LTC2175-14: SNR vs Input Frequency, -1dB, 2V Range, 125Msps

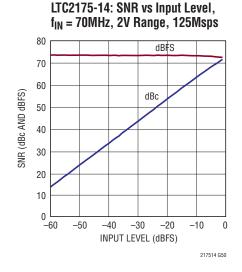


21754314p



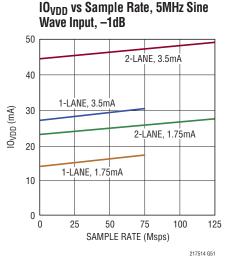


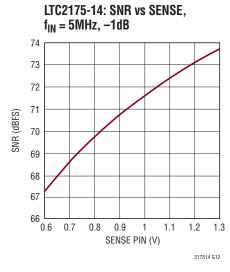


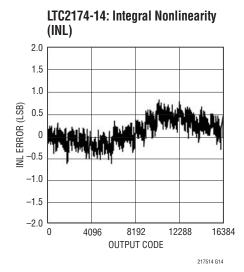


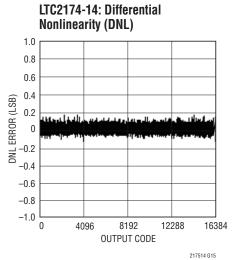
LTC2175-14: l_{VDD} vs Sample Rate,
5MHz Sine Wave Input, -1dB

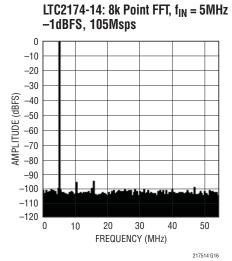
290
280
270
260
250
240
230
210
25 50 75 100 125
SAMPLE RATE (Msps)







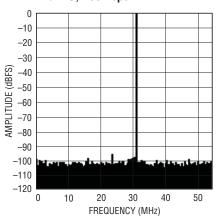




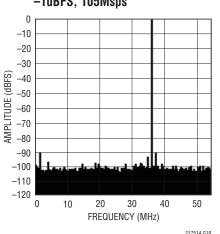
21754314p



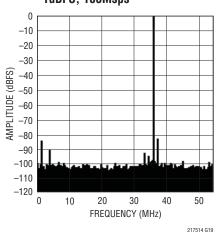




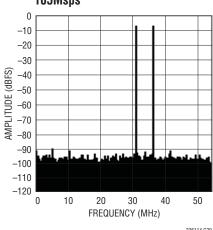
LTC2174-14: 8k Point FFT, $f_{IN} = 70MHz$ -1dBFS, 105Msps



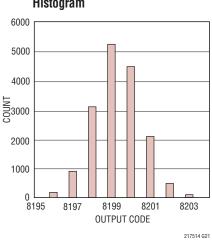
LTC2174-14: 8k Point FFT, f_{IN} = 140MHz -1dBFS, 105Msps



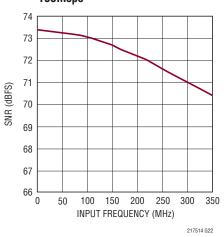
LTC2174-14: 8k Point 2-Tone FFT, $f_{\text{IN}} = 70\text{MHz}, 75\text{MHz}, -1\text{dBFS}, 105\text{Msps}$



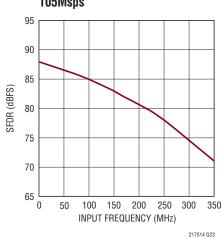
LTC2174-14: Shorted Input Histogram



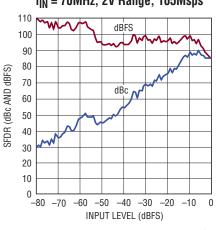
LTC2174-14: SNR vs Input Frequency, -1dB, 2V Range, 105Msps



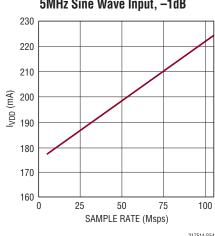
LTC2174-14: SFDR vs Input Frequency, -1dB, 2V Range, 105Msps

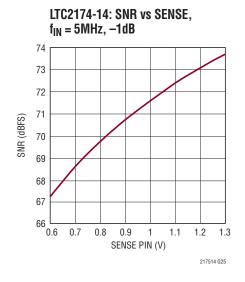


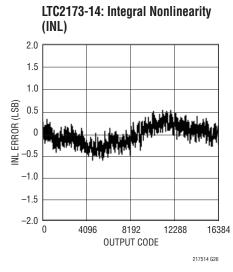
LTC2174-14: SFDR vs Input Level, f_{IN} = 70MHz, 2V Range, 105Msps

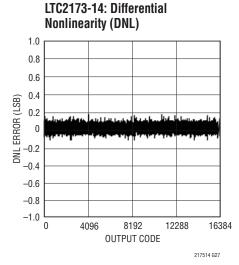


LTC2174-14: I_{VDD} vs Sample Rate, 5MHz Sine Wave Input, -1dB

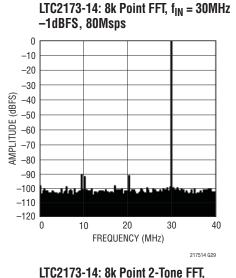


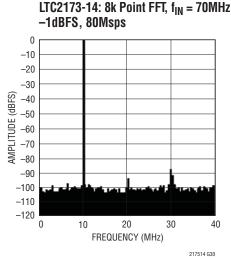


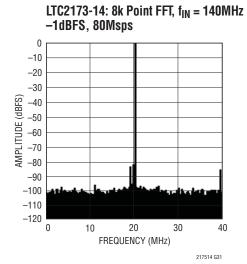


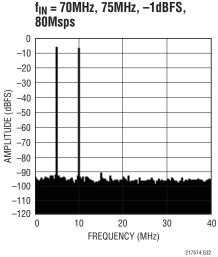


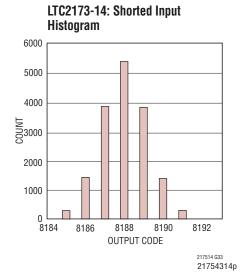
LTC2173-14: 8k Point FFT, $f_{IN} = 5MHz$ -1dBFS, 80Msps 0 -10 -20 -30 AMPLITUDE (dBFS) -40 -50 -60 -70 -80 -90 -100 -110 -120 20 30 0 10 40 FREQUENCY (MHz)







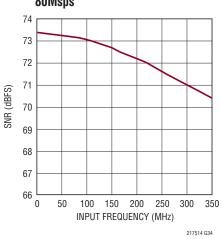




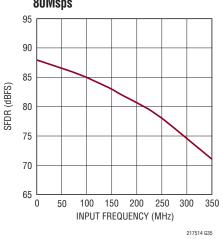


14

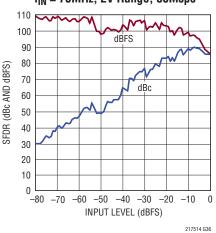
LTC2173-14: SNR vs Input Frequency, -1dB, 2V Range, 80Msps



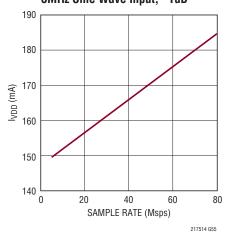
LTC2173-14: SFDR vs Input Frequency, -1dB, 2V Range, 80Msps



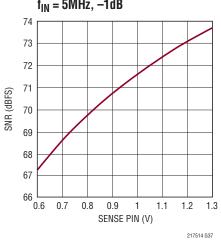
LTC2173-14: SFDR vs Input Level, f_{IN} = 70MHz, 2V Range, 80Msps



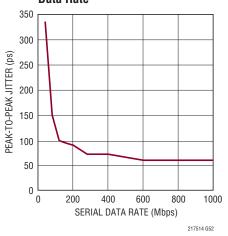
LTC2173-14: I_{VDD} vs Sample Rate, 5MHz Sine Wave Input, -1dB



LTC2173-14: SNR vs SENSE, $f_{IN} = 5MHz, -1dB$



DCO Cycle-Cycle Jitter vs Serial Data Rate



PIN FUNCTIONS

A_{IN1}⁺ **(Pin 1)**: Channel 1 Positive Differential Analog Input.

A_{IN1} (**Pin 2**): Channel 1 Negative Differential Analog Input.

 V_{CM12} (Pin 3): Common Mode Bias Output, Nominally Equal to $V_{DD}/2$. V_{CM} should be used to bias the common mode of the analog inputs of channels 1 and 2. Bypass to ground with a $0.1\mu F$ ceramic capacitor.

A_{IN2}⁺ (Pin 4): Channel 2 Positive Differential Analog Input.

A_{IN2} (**Pin 5**): Channel 2 Negative Differential Analog Input.

REFH (Pins 6,7): ADC High Reference. Bypass to pins 8, 9 with a $2.2\mu F$ ceramic capacitor and to ground with a $0.1\mu F$ ceramic capacitor.

REFL (Pins 8,9): ADC Low Reference. Bypass to pins 6, 7 with a $2.2\mu\text{F}$ ceramic capacitor and to ground with a $0.1\mu\text{F}$ ceramic capacitor.

A_{IN3}⁺ (**Pin 10**): Channel 3 Positive Differential Analog Input.

A_{IN3} (**Pin 11**): Channel 3 Negative Differential Analog Input.

 V_{CM34} (Pin 12): Common Mode Bias Output, Nominally Equal to $V_{DD}/2$. V_{CM} should be used to bias the common mode of the analog inputs of channels 3 and 4. Bypass to ground with a $0.1\mu F$ ceramic capacitor.

A_{IN4}⁺ (**Pin 13**): Channel 4 Positive Differential Analog Input.

A_{IN4} (**Pin 14**): Channel 4 Negative Differential Analog Input.

 V_{DD} (Pins 15, 16, 51, 52): 1.8V Analog Power Supply. Bypass to ground with $0.1\mu F$ ceramic capacitors. Adjacent pins can share a bypass capacitor.

ENC+ (Pin 17): Encode Input. Conversion starts on the rising edge.

ENC⁻ (**Pin 18**): Encode Complement Input. Conversion starts on the falling edge.

 $\overline{\text{CS}}$ (Pin 19): In serial programming mode, (PAR/ $\overline{\text{SER}}$ = 0V), $\overline{\text{CS}}$ is the serial interface chip select input. When $\overline{\text{CS}}$ is low, SCK is enabled for shifting data on SDI into the mode control registers. In the parallel programming mode (PAR/ $\overline{\text{SER}}$ = V_{DD}), $\overline{\text{CS}}$ selects 2-lane or 1-lane output mode. $\overline{\text{CS}}$ can be driven with 1.8V to 3.3V logic.

SCK (Pin 20): In serial programming mode, (PAR/ \overline{SER} = 0V), SCK is the serial interface clock input. In the parallel programming mode (PAR/ \overline{SER} = V_{DD}), SCK selects 3.5mA or 1.75mA LVDS output currents. SCK can be driven with 1.8V to 3.3V logic.

SDI (Pin 21): In serial programming mode, (PAR/ \overline{SER} = 0V), SDI is the serial interface data Input. Data on SDI is clocked into the mode control registers on the rising edge of SCK. In the parallel programming mode (PAR/ \overline{SER} = V_{DD}), SDI can be used to power down the part. SDI can be driven with 1.8V to 3.3V logic.

GND (Pins 22, 45, 49): ADC Power Ground.

OGND (Pin 33): Output Driver Ground.

 OV_{DD} (Pin 34): Output Driver Supply. Bypass to ground with a $0.1\mu F$ ceramic capacitor.

SDO (Pin 46): In serial programming mode, (PAR/ \overline{SER} = 0V), SDO is the optional serial interface data output. Data on SDO is read back from the mode control registers and can be latched on the falling edge of SCK. SDO is an open-drain NMOS output that requires an external 2k pull-up resistor to 1.8V – 3.3V. If read back from the mode control registers is not needed, the pull-up resistor is not necessary and SDO can be left unconnected. In the parallel programming mode (PAR/ \overline{SER} = V_{DD}), SDO is an input that enables internal 100 Ω termination resistors on the digital outputs. When used as an input, SDO can be driven with 1.8V to 3.3V logic through a 1k series resistor.

PAR/SER (**Pin 47**): Programming Mode Selection Pin. Connect to ground to enable the serial programming mode. \overline{CS} , SCK, SDI, SDO become a serial interface that control the A/D operating modes. Connect to V_{DD} to enable the parallel programming mode where \overline{CS} , SCK, SDI, SDO become parallel logic inputs that control a reduced set of the A/D operating modes. PAR/ \overline{SER} should be connected directly to ground or the V_{DD} of the part and not be driven by a logic signal.

21754314p



PIN FUNCTIONS

 V_{REF} (Pin 48): Reference Voltage Output. Bypass to ground with a 1µF ceramic capacitor, nominally 1.25V.

SENSE (Pin 50): Reference Programming Pin. Connecting SENSE to V_{DD} selects the internal reference and a $\pm 1V$ input range. Connecting SENSE to ground selects the internal reference and a $\pm 0.5V$ input range. An external reference between 0.625V and 1.3V applied to SENSE selects an input range of $\pm 0.8 \cdot V_{SENSE}$.

Exposed Pad (Pin 53): Ground. The Exposed Pad must be soldered to the PCB ground.

LVDS Outputs

All pins in this section are differential LVDS outputs. The output current level is programmable. There is an optional internal 100 Ω termination resistor between the pins of each LVDS output pair.

OUT4B⁺/**OUT4B**⁺, **OUT4A**⁻/**OUT4A**⁺ (**Pins 23/24, 25/26**): Serial data outputs for Channel 4. In 1-lane output mode only OUT4A⁻/OUT4A⁺ are used.

OUT3B⁻/OUT3B⁺, OUT3A⁻/OUT3A⁺ (Pins 27/28, 29/30): Serial data outputs for Channel 3. In 1-lane output mode only OUT3A⁻/OUT3A⁺ are used.

FR⁻/FR⁺ (Pins 31/32): Frame Start Outputs.

DCO⁻/DCO⁺ (Pins 35/36): Data Clock Outputs.

OUT2B⁻/OUT2B⁺, OUT2A⁻/OUT2A⁺ (Pins 37/38, 39/40): Serial data outputs for Channel 2. In 1-lane output mode only OUT2A⁻/OUT2A⁺ are used.

OUT1B⁺/OUT1B⁺, OUT1A⁻/OUT1A⁺ (Pins 41/42, 43/44): Serial data outputs for Channel 1. In 1-lane output mode only OUT1A⁻/OUT1A⁺ are used.



FUNCTIONAL BLOCK DIAGRAM

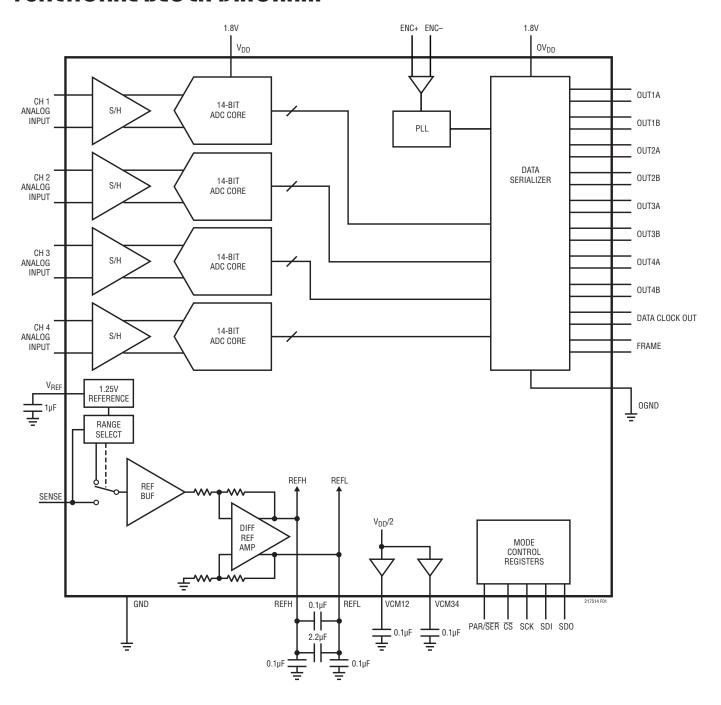


Figure 1. Functional Block Diagram

CONVERTER OPERATION

The LTC2175-14/LTC2174-14/LTC2173-14 are low power, 4-channel, 14-bit, 125Msps/105Msps/80Msps A/D converters that are powered by a single 1.8V supply. The analog inputs should be driven differentially. The encode input can be driven differentially for optimal jitter performance, or single ended for lower power consumption. The digital outputs are serial LVDS to minimize the number of data lines. Each channel outputs two bits at a time (2-lane mode). At lower sampling rates there is a one bit per channel option (1-lane mode). Many additional features can be chosen by programming the mode control registers through a serial SPI port.

ANALOG INPUT

The analog inputs are differential CMOS sample-and-hold circuits (Figure 2). The inputs should be driven differentially around a common mode voltage set by the V_{CM12} or V_{CM34} output pins, which are nominally $V_{DD}/2$. For the

LTC2175-14
VDD

10Ω
AIN

CSAMPLE
3.5pF

1.8pF

CPARASITIC
1.8pF

CPARASITIC
1.8pF

1.2V

1.2V

1.2V

1.2V

1.2V

1.2V

1.2V

1.2V

1.2V

Figure 2. Equivalent Input Circuit. Only One of the Four Analog Channels is Shown.

2V input range, the inputs should swing from $V_{CM}-0.5V$ to $V_{CM}+0.5V$. There should be 180° phase difference between the inputs.

The four channels are simultaneously sampled by a shared encode circuit (Figure 2).

INPUT DRIVE CIRCUITS

Input Filtering

If possible, there should be an RC low pass filter right at the analog inputs. This lowpass filter isolates the drive circuitry from the A/D sample-and-hold switching, and also limits wideband noise from the drive circuitry. Figure 3 shows an example of an input RC filter. The RC component values should be chosen based on the application's input frequency.

Transformer Coupled Circuits

Figure 3 shows the analog input being driven by an RF transformer with a center-tapped secondary. The center

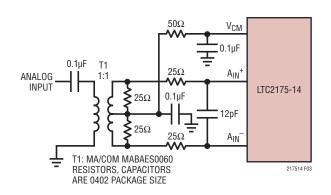


Figure 3. Analog Input Circuit Using a Transformer.

Recommended for Input Frequencies from 5MHz to 70MHz.

tap is biased with V_{CM} , setting the A/D input at its optimal DC level. At higher input frequencies a transmission line balun transformer (Figures 4 to 6) has better balance, resulting in lower A/D distortion.

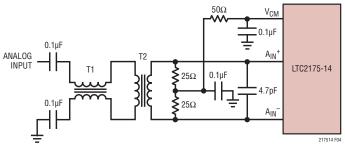
Amplifier Circuits

Figure 7 shows the analog input being driven by a high speed differential amplifier. The output of the amplifier is AC-coupled to the A/D so the amplifier's output common mode voltage can be optimally set to minimize distortion.

At very high frequencies an RF gain block will often have lower distortion than a differential amplifier. If the gain block is single-ended, then a transformer circuit (Figures 4 to 6) should convert the signal to differential before driving the A/D.

Reference

The LTC2175-14/LTC2174-14/LTC2173-14 has an internal 1.25V voltage reference. For a 2V input range using the internal reference, connect SENSE to V_{DD} . For a 1V input range using the internal reference, connect SENSE to



T1: MA/COM MABA-007159-000000
T2: MA/COM MABAES0060
RESISTORS, CAPACITORS ARE 0402 PACKAGE SIZE

Figure 4. Recommended Front End Circuit for Input Frequencies from 70MHz to 170MHz

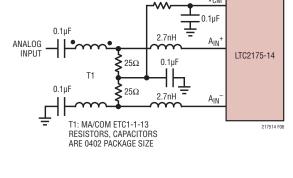
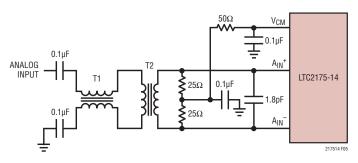


Figure 6. Recommended Front End Circuit for Input Frequencies Above 300MHz



T1: MA/COM MABA-007159-000000 T2: COILCRAFT WBC1-1LB RESISTORS, CAPACITORS ARE 0402 PACKAGE SIZE

Figure 5. Recommended Front End Circuit for Input Frequencies from 170MHz to 300MHz

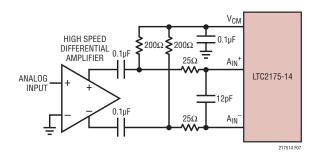


Figure 7. Front End Circuit Using a High Speed Differential Amplifier

ground. For a 2V input range with an external reference, apply a 1.25V reference voltage to SENSE (Figure 9).

The input range can be adjusted by applying a voltage to SENSE that is between 0.625V and 1.30V. The input range will then be $1.6 \cdot V_{SENSE}$.

The reference is shared by all four ADC channels, so it is not possible to independently adjust the input range of individual channels.

The V_{REF} , REFH and REFL pins should be bypassed as shown in Figure 8. The 0.1 μ F capacitor between REFH

and REFL should be as close to the pins as possible (not on the backside of the circuit board).

Encode Input

The signal quality of the encode inputs strongly affects the A/D noise performance. The encode inputs should be treated as analog signals—do not route them next to digital traces on the circuit board. There are two modes of operation for the encode inputs: the differential encode mode (Figure 10), and the single-ended encode mode (Figure 11).

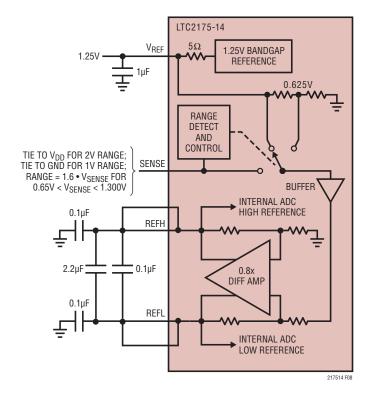


Figure 8. Reference Circuit

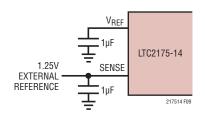


Figure 9. Using an External 1.25V Reference

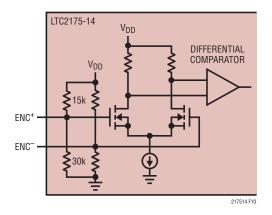


Figure 10. Equivalent Encode Input Circuit for Differential Encode Mode

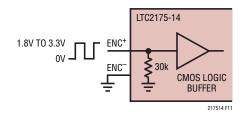


Figure 11. Equivalent Encode Input Circuit for Single-Ended Encode Mode

The differential encode mode is recommended for sinusoidal, PECL, or LVDS encode inputs (Figures 12 and 13). The encode inputs are internally biased to 1.2V through 10k equivalent resistance. The encode inputs can be taken above V_{DD} (up to 3.6V), and the common mode range is from 1.1V to 1.6V. In the differential encode mode, ENC⁻ should stay at least 200mV above ground to avoid falsely triggering the single-ended encode mode. For good jitter performance ENC⁺ should have fast rise and fall times.

The single-ended encode mode should be used with CMOS encode inputs. To select this mode, ENC $^-$ is connected to ground and ENC $^+$ is driven with a square wave encode input. ENC $^+$ can be taken above V $_{DD}$ (up to 3.6V) so 1.8V to 3.3V CMOS logic levels can be used. The ENC $^+$ threshold

is 0.9V. For good jitter performance ENC⁺ should have fast rise and fall times.

Clock PLL and Duty Cycle Stabilizer

The encode clock is multiplied by an internal phase-locked loop (PLL) to generate the serial digital output data. If the encode signal changes frequency or is turned off, the PLL requires $25\mu s$ to lock onto the input clock.

A clock duty cycle stabilizer circuit allows the duty cycle of the applied encode signal to vary from 30% to 70%. In the serial programming mode it is possible to disable the duty cycle stabilizer, but this is not recommended. In the parallel programming mode the duty cycle stabilizer is always enabled.

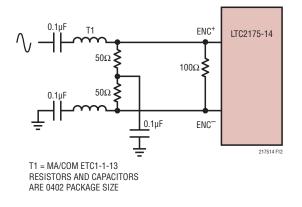


Figure 12. Sinusoidal Encode Drive

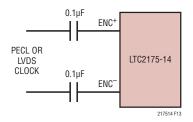


Figure 13. PECL or LVDS Encode Drive

DIGITAL OUTPUTS

The digital outputs of the LTC2175-14/LTC2174-14/LTC2173-14 are serialized LVDS signals. Each channel outputs two bits at a time (2-lane mode). At lower sampling rates there is a one bit per channel option (1-lane mode). The data can be serialized with 16, 14, or 12-bit serialization (see timing diagrams for details). Note that with 12-bit serialization the two LSBs are not available—this mode is included for compatibility with the 12-bit versions of these parts.

The output data should be latched on the rising and falling edges of the data clock out (DCO). A data frame output (FR) can be used to determine when the data from a new conversion result begins. In the 2-lane, 14-bit serialization mode, the frequency of the FR output is halved.

The maximum serial data rate for the data outputs is 1Gbps, so the maximum sample rate of the ADC will depend on the serialization mode as well as the speed grade of the ADC (see Table 1). The minimum sample rate for all serialization modes is 5Msps.

By default the outputs are standard LVDS levels: 3.5mA output current and a 1.25V output common mode voltage. An external 100Ω differential termination resistor is required for each LVDS output pair. The termination

resistors should be located as close as possible to the LVDS receiver.

The outputs are powered by OV_{DD} and OGND which are isolated from the A/D core power and ground.

Programmable LVDS Output Current

The default output driver current is 3.5mA. This current can be adjusted by control register A2 in the serial programming mode. Available current levels are 1.75mA, 2.1mA, 2.5mA, 3mA, 3.5mA, 4mA and 4.5mA. In the parallel programming mode the SCK pin can select either 3.5mA or 1.75mA.

Optional LVDS Driver Internal Termination

In most cases using just an external 100Ω termination resistor will give excellent LVDS signal integrity. In addition, an optional internal 100Ω termination resistor can be enabled by serially programming mode control register A2. The internal termination helps absorb any reflections caused by imperfect termination at the receiver. When the internal termination is enabled, the output driver current is doubled to maintain the same output voltage swing. In the parallel programming mode the SDO pin enables internal termination.

Table 1. Maximum Sampling Frequency for All Serialization Modes. Note That These Limits Are for the LTC2175-14. The Sampling Frequency for the Slower Speed Grades Cannot Exceed 105MHz (LTC2174-14) or 80MHz (LTC2173-14).

| SERIALIZAT | TION MODE | MAXIMUM SAMPLING FREQUENCY, f _S (MHz) | DCO FREQUENCY | FR FREQUENCY | SERIAL DATA RATE |
|------------|----------------------|-----------------------------------------------------|----------------------|----------------------|---------------------|
| 2-Lane | 16-Bit Serialization | 125 | 4 • f _S | f _S | 8 • f _S |
| 2-Lane | 14-Bit Serialization | 125 | 3.5 • f _S | 0.5 • f _S | 7 • f _S |
| 2-Lane | 12-Bit Serialization | 125 | 3 • f _S | f _S | 6 • f _S |
| 1-Lane | 16-Bit Serialization | 62.5 | 8 • f _S | f _S | 16 • f _S |
| 1-Lane | 14-Bit Serialization | 71.4 | 7 • f _S | f _S | 14 • f _S |
| 1-Lane | 12-Bit Serialization | 83.3 | 6 • f _S | f _S | 12 • f _S |

DATA FORMAT

Table 2 shows the relationship between the analog input voltage and the digital data output bits. By default the output data format is offset binary. The 2's complement format can be selected by serially programming mode control register A1.

Table 2. Output Codes vs Input Voltage

| A _{IN} ⁺ – A _{IN} ⁻ (2V RANGE) | D13-D0 (OFFSET BINARY) | D13-D0 (2's COMPLEMENT) |
|---------------------------------------------------------------------------|---------------------------|----------------------------|
| >1.000000V | 11 1111 1111 1111 | 01 1111 1111 1111 |
| +0.999878V | 11 1111 1111 1111 | 01 1111 1111 1111 |
| +0.999756V | 11 1111 1111 1110 | 01 1111 1111 1110 |
| +0.000122V | 10 0000 0000 0001 | 00 0000 0000 0001 |
| +0.000000V | 10 0000 0000 0000 | 00 0000 0000 0000 |
| -0.000122V | 01 1111 1111 1111 | 11 1111 1111 1111 |
| -0.000244V | 01 1111 1111 1110 | 11 1111 1111 1110 |
| -0.999878V | 00 0000 0000 0001 | 10 0000 0000 0001 |
| -1.000000V | 00 0000 0000 0000 | 10 0000 0000 0000 |
| <-1.000000V | 00 0000 0000 0000 | 10 0000 0000 0000 |

Digital Output Randomizer

Interference from the A/D digital outputs is sometimes unavoidable. Digital interference may be from capacitive or inductive coupling or coupling through the ground plane. Even a tiny coupling factor can cause unwanted tones in the ADC output spectrum. By randomizing the digital output before it is transmitted off chip, these unwanted tones can be randomized which reduces the unwanted tone amplitude.

The digital output is *randomized* by applying an exclusive-OR logic operation between the LSB and all other data output bits. To decode, the reverse operation is applied—an exclusive-OR operation is applied between the LSB

and all other bits. The FR and DCO outputs are not affected. The output randomizer is enabled by serially programming mode control register A1.

Digital Output Test Pattern

To allow in-circuit testing of the digital interface to the A/D, there is a test mode that forces the A/D data outputs (D13-D0) of all channels to known values. The digital output test patterns are enabled by serially programming mode control registers A3 and A4. When enabled, the test patterns override all other formatting modes: 2's complement and randomizer.

Output Disable

The digital outputs may be disabled by serially programming mode control register A2. The current drive for all digital outputs including DCO and FR are disabled to save power or enable in-circuit testing. When disabled the common mode of each output pair becomes high impedance, but the differential impedance may remain low.

Sleep and Nap Modes

The A/D may be placed in sleep or nap modes to conserve power. In sleep mode the entire chip is powered down, resulting in 1mW power consumption. Sleep mode is enabled by mode control register A1 (serial programming mode), or by SDI (parallel programming mode). The amount of time required to recover from sleep mode depends on the size of the bypass capacitors on V_{REF} , REFH, and REFL. For the suggested values in Figure 8, the A/D will stabilize after 2ms.

In nap mode any combination of A/D channels can be powered down while the internal reference circuits and the PLL stay active, allowing faster wakeup than from sleep



mode. Recovering from nap mode requires at least 100 clock cycles. If the application demands very accurate DC settling then an additional 50µs should be allowed so the on-chip references can settle from the slight temperature shift caused by the change in supply current as the A/D leaves nap mode. Nap mode is enabled by mode control register A1 in the serial programming mode.

DEVICE PROGRAMMING MODES

The operating modes of the LTC2175-14/LTC2174-14/LTC2173-14 can be programmed by either a parallel interface or a simple serial interface. The serial interface has more flexibility and can program all available modes. The parallel interface is more limited and can only program some of the more commonly used modes.

Parallel Programming Mode

To use the parallel programming mode, PAR/ \overline{SER} should be tied to V_{DD} . The \overline{CS} , SCK, SDI and SDO pins are binary logic inputs that set certain operating modes. These pins can be tied to V_{DD} or ground, or driven by 1.8V, 2.5V, or 3.3V CMOS logic. When used as an input, SDO should be driven through a 1k series resistor. Table 3 shows the modes set by \overline{CS} , SCK, SDI and SDO.

Serial Programming Mode

To use the serial programming mode, PAR/SER should be tied to ground. The \overline{CS} , SCK, SDI and SDO pins become a serial interface that program the A/D mode control registers. Data is written to a register with a 16-bit serial word. Data can also be read back from a register to verify its contents.

Serial data transfer starts when \overline{CS} is taken low. The data on the SDI pin is latched at the first 16 rising edges of SCK. Any SCK rising edges after the first 16 are ignored. The data transfer ends when \overline{CS} is taken high again.

The first bit of the 16-bit input word is the R/\overline{W} bit. The next seven bits are the address of the register (A6:A0). The final eight bits are the register data (D7:D0).

If the R/\overline{W} bit is low, the serial data (D7:D0) will be written to the register set by the address bits (A6:A0). If the R/\overline{W} bit is high, data in the register set by the address bits (A6:A0) will be read back on the SD0 pin (see the Timing Diagrams sections). During a read back command the register is not updated and data on SDI is ignored.

The SDO pin is an open-drain output that pulls to ground with a 200Ω impedance. If register data is read back through SDO, an external 2k pull-up resistor is required. If serial

Table 3. Parallel Programming Mode Control Bits (PAR/ $\overline{SER} = V_{DD}$)

| Pin | DESCRIPTION |
|-----|----------------------------------------------|
| CS | 2-Lane / 1-Lane Selection Bit |
| | 0 = 2-Lane, 16-Bit Serialization Output Mode |
| | 1 = 1-Lane, 14-Bit Serialization Output Mode |
| SCK | LVDS Current Selection Bit |
| | 0 = 3.5mA LVDS Current Mode |
| | 1 = 1.75mA LVDS Current Mode |
| SDI | Power Down Control Bit |
| | 0 = Normal Operation |
| | 1 = Sleep Mode |
| SD0 | Internal Termination Selection Bit |
| | 0 = Internal Termination Disabled |
| | 1 = Internal Termination Enabled |

data is only written and read back is not needed, then SDO can be left floating and no pull-up resistor is needed. Table 4 shows a map of the mode control registers.

Software Reset

If serial programming is used, the mode control registers should be programmed as soon as possible after the power supplies turn on and are stable. The first serial command must be a software reset which will reset all register data bits to logic 0. To perform a software reset, bit D7 in the reset register is written with a logic 1. After the reset is complete, bit D7 is automatically set back to zero.

GROUNDING AND BYPASSING

The LTC2175-14/LTC2174-14/LTC2173-14 requires a printed circuit board with a clean unbroken ground plane. A multilayer board with an internal ground plane is recommended. Layout for the printed circuit board should ensure that digital and analog signal lines are separated as much as possible. In particular, care should be taken not to run any digital track alongside an analog signal track or underneath the ADC.

High quality ceramic bypass capacitors should be used at the V_{DD}, OV_{DD}, V_{CM}, V_{RFF}, REFH and REFL pins. Bypass capacitors must be located as close to the pins as possible. Of particular importance is the 0.1µF capacitor between REFH and REFL. This capacitor should be on the same side of the circuit board as the A/D, and as close to the device as possible (1.5mm or less). Size 0402 ceramic capacitors are recommended. The larger 2.2uF capacitor between REFH and REFL can be somewhat further away. The traces connecting the pins and bypass capacitors must be kept short and should be made as wide as possible.

The analog inputs, encode signals, and digital outputs should not be routed next to each other. Ground fill and grounded vias should be used as barriers to isolate these signals from each other.

HEAT TRANSFER

Most of the heat generated by the LTC2175-14/LTC2174-14/ LTC2173-14 is transferred from the die through the bottom-side Exposed Pad and package leads onto the printed circuit board. For good electrical and thermal performance. the Exposed Pad must be soldered to a large grounded pad on the PC board.

Table 4. Serial Programming Mode Register Map (PAR/ \overline{SER} = GND) REGISTER AO: RESET REGISTER (ADDRESS 00h)

| D7 | D6 | D5 | D4 | D3 | D2 | D1 | D0 |
|-------|--------------|--------------------|----|----|----|----|----|
| RESET | Х | X | Χ | Х | Х | Х | X |
| Bit 7 | RESET | Software Reset Bit | | | | | |
| | 0 = Not Used | | | | | | |

1 = Software Reset. All Mode Control Registers are Reset to 00h. The ADC is Momentarily Placed in SLEEP Mode.

This Bit is Automatically Set Back to Zero After the Reset is Complete

Bits 6-0 Unused, Don't Care Bits.

REGISTER A1: FORMAT AND POWER-DOWN REGISTER (ADDRESS 01h)

| D7 | D6 | D5 | D4 | D3 | D2 | D1 | D0 |
|--------|------|----------|-------|-------|-------|-------|-------|
| DCSOFF | RAND | TWOSCOMP | SLEEP | NAP_4 | NAP_3 | NAP_2 | NAP_1 |

Bit 7 **DCSOFF** Clock Duty Cycle Stabilizer Bit

0 = Clock Duty Cycle Stabilizer On

1 = Clock Duty Cycle Stabilizer Off. This is Not Recommended.

Bit 6 Data Output Randomizer Mode Control Bit

0 = Data Output Randomizer Mode Off 1 = Data Output Randomizer Mode On

Bit 5 TWOSCOMP Two's Complement Mode Control Bit

0 = Offset Binary Data Format 1 = Two's Complement Data Format

Bits 4-0 SLEEP: NAP_4:NAP_1 Sleep/Nap Mode Control Bits

00000 = Normal Operation
0XXX1 = Channel 1 in Nap Mode
0XX1X = Channel 2 in Nap Mode
0X1XX = Channel 3 in Nap Mode
01XXX = Channel 4 in Nap Mode

1XXXX = Sleep Mode. All Channels are Disabled

Note: Any Combination of Channels Can Be Placed in Nap Mode.

REGISTER A2: OUTPUT MODE REGISTER (ADDRESS 02h)

| D7 | D6 | D5 | D4 | D3 | D2 | D1 | D0 |
|----------|-----------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|--------|--------|--------|----------|----------|----------|
| ILVDS2 | ILVDS1 | ILVDS0 | TERMON | OUTOFF | OUTMODE2 | OUTMODE1 | OUTMODE0 |
| Bits 7-5 | ILVDS2:ILVDS0 LVDS Output Current Bits 000 = 3.5mA LVDS Output Driver Current 001 = 4.0mA LVDS Output Driver Current 010 = 4.5mA LVDS Output Driver Current 011 = Not Used 100 = 3.0mA LVDS Output Driver Current 101 = 2.5mA LVDS Output Driver Current 110 = 2.1mA LVDS Output Driver Current 111 = 1.75mA LVDS Output Driver Current | | | | | | |
| Bit 4 | TERMON LVDS Internal Termination Bit 0 = Internal Termination Off 1 = Internal Termination On. LVDS Output Driver Current is 2x the Current Set by ILVDS2:ILVDS0 | | | | | | |
| Bit 3 | OUTOFF Output Disable Bit 0 = Digital Outputs are Enabled. 1 = Digital Outputs are Disabled. | | | | | | |
| Bits 2-0 | OUTMODE2:OUTMODE0 Digital Output Mode Control Bits 000 = 2-Lanes, 16-Bit Serialization 001 = 2-Lanes, 14-Bit Serialization 010 = 2-Lanes, 12-Bit Serialization 011 = Not Used 100 = Not Used 101 = 1-Lane, 14-Bit Serialization 110 = 1-Lane, 12-Bit Serialization 111 = 1-Lane, 16-Bit Serialization | | | | | | |

REGISTER A3: TEST PATTERN MSB REGISTER (ADDRESS 03h)

| D7 | D6 | D5 | D4 | D3 | D2 | D1 | D0 |
|---------|------------------------------------------------------------------------------------------------------------------------------|------|------|------|------|-----|-----|
| OUTTEST | X | TP13 | TP12 | TP11 | TP10 | TP9 | TP8 |
| Bit 7 | OUTTEST Digital Output Test Pattern Control Bit 0 = Digital Output Test Pattern Off 1 = Digital Output Test Pattern On | | | | | | |
| Bit 6 | Unused, Don't Care Bit. | | | | | | |
| Bit 5-0 | TP13:TP8 Test Pattern Data Bits (MSB) TP13:TP8 Set the Test Pattern for Data Bit 13(MSB) Through Data Bit 8. | | | | | | |

REGISTER A4: TEST PATTERN LSB REGISTER (ADDRESS 04h)

| D7 | D6 | D5 | D4 | D3 | D2 | D1 | D0 |
|-----|-----|-----|-----|-----|-----|-----|-----|
| TP7 | TP6 | TP5 | TP4 | TP3 | TP2 | TP1 | TP0 |

Bit 7-0 Test Pattern Data Bits (LSB)

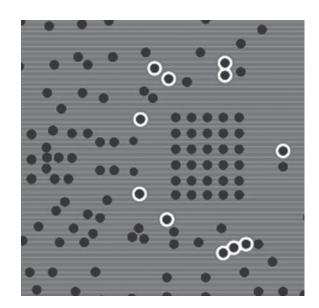
TP7:TP0 Set the Test Pattern for Data Bit 7 Through Data Bit 0(LSB).



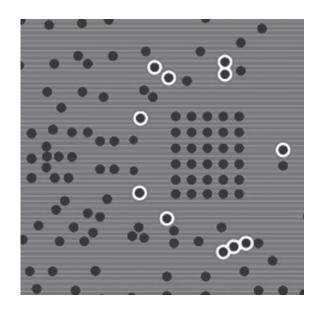
TYPICAL APPLICATIONS

Top Side

Inner Layer 2 GND

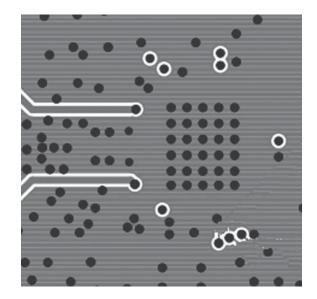


Inner Layer 3

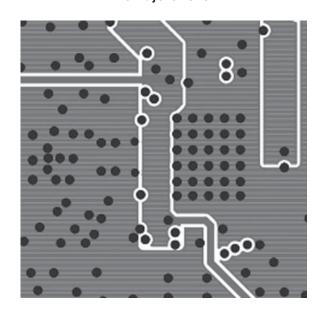


TYPICAL APPLICATIONS

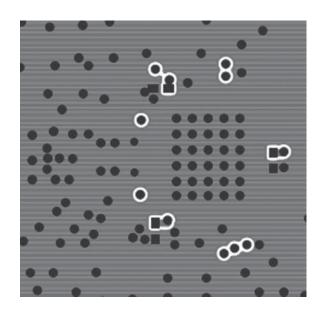
Inner Layer 4



Inner Layer 5 Power



Bottom Side

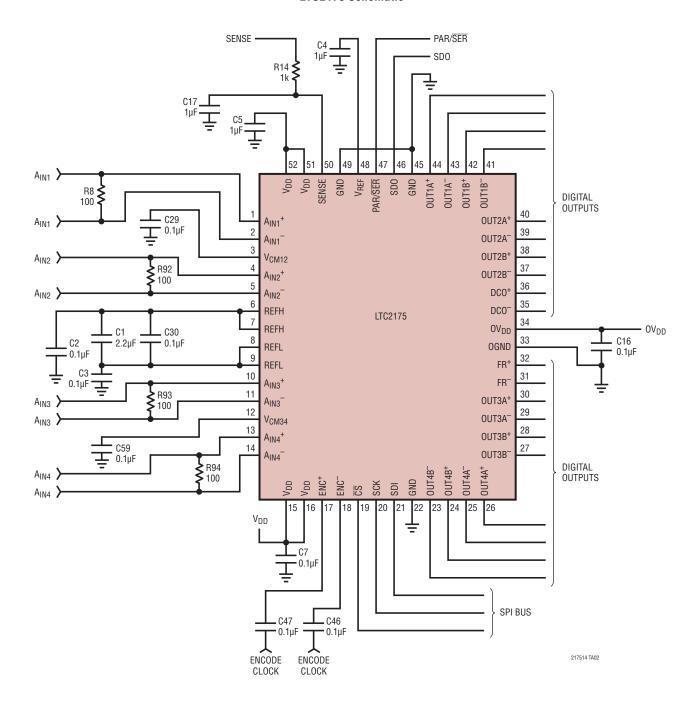


Silkscreen Bottom



TYPICAL APPLICATIONS

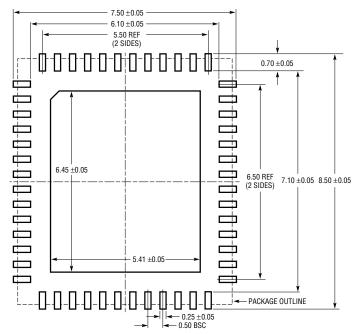
LTC2175 Schematic



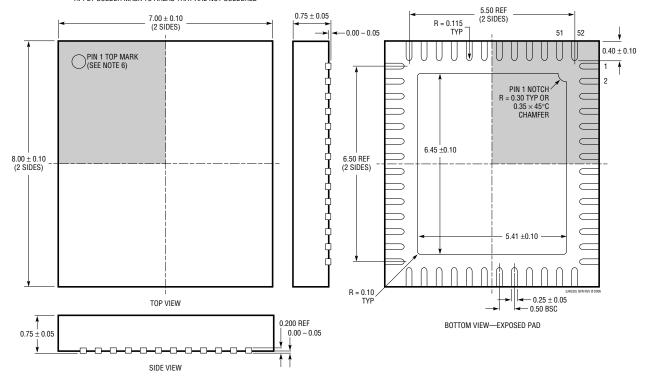
PACKAGE DESCRIPTION

UKG Package 52-Lead Plastic QFN (7mm × 8mm)

(Reference LTC DWG # 05-08-1729 Rev Ø)



RECOMMENDED SOLDER PAD PITCH AND DIMENSIONS APPLY SOLDER MASK TO AREAS THAT ARE NOT SOLDERED



NOTE:

- 1. DRAWING IS NOT A JEDEC PACKAGE OUTLINE
- 2. DRAWING NOT TO SCALE
 3. ALL DIMENSIONS ARE IN MILLIMETERS
- 4. DIMENSIONS OF EXPOSED PAD ON BOTTOM OF PACKAGE DO NOT INCLUDE MOLD FLASH. MOLD FLASH, IF PRESENT, SHALL NOT EXCEED 0.20mm ON ANY SIDE, IF PRESENT
- 5. EXPOSED PAD SHALL BE SOLDER PLATED.
- 6. SHADED AREA IS ONLY A REFERENCE FOR PIN 1 LOCATION ON THE TOP AND BOTTOM OF PACKAGE



21754314p

LTC2175-14/ LTC2174-14/LTC2173-14

RELATED PARTS

| Inc2206-14/11C2205 16-Bit, 40Msps:/65Msps 3.3 y ADCS 480mW/590mW, 79dB SNR, 100dB SFDR, CMOS Outputs, 7mm ~ 7mm CPN-48 11C2205-14/11C2206-14/11C2205-14/11C2206-14/11C2207-14 14-Bit, 50Msps:80Msps/105Msps 3.3 y ADC 1250mW, 77-36B SNR, 100dB SFDR, CMOS Outputs, 7mm ~ 7mm CPN-48 11C2208-14 14-Bit, 130Msps 3.3 y ADC 1250mW, 77-16B SNR, 100dB SFDR, CMOS Outputs, 9mm ~ 9mm CPN-49 11C2208-14 14-Bit, 130Msps 3.3 y ADC 1350mW, 77-16B SNR, 100dB SFDR, LVDS Outputs, 9mm ~ 9mm CPN-49 11C2208-14 14-Bit, 130Msps 3.3 y ADC 1350mW, 77-16B SNR, 100dB SFDR, LVDS Outputs, 9mm ~ 9mm CPN-49 11C2205-14/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C2216/11C216/11C216/11C216/11C216/11C216/11C216/11C216/11C216/11C216/11C216/11C216/11C216/11C216/11C216/ | PART NUMBER | DESCRIPTION | COMMENTS |
|-------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|--------------------------------------|------------------------------------------------------------------|-------------------------------------------------------------------------------------------------------------------------|
| TIC2172-14 | ADCs | | |
| ILCO217-12 1.8V Quad ADOS, Ultralow Power 7mm x mm OFN-52 17mm x mm OFN-64 17mm | | | |
| ILC22167-12 | | | |
| ITC2296-14/TC2205 16-Bit, 40Msps/65Msps 3.3 V ADC | | 12-Bit, 80Msps/105Msps/125Msps 1.8V Quad ADCs, Ultralow Power | |
| LTC2226-1417LC2266-142 14-Bit, 65Msps/105Msps | LTC2202/LTC2203 | 16-Bit, 10Msps/25Msps, 3.3V ADCs | 140mW/220mW, 81.6dB SNR, 100dB SFDR, CMOS Outputs, 7mm × 7mm QFN-48 |
| LTC22907-14 3.3V ADCS | LTC2204/LTC2205 | 16-Bit, 40Msps/65Msps 3.3V ADCs | 480mW/590mW, 79dB SNR, 100dB SFDR, CMOS Outputs, 7mm × 7mm QFN-48 |
| ITC2208 | | | |
| ITC2208-14 | LTC2206/LTC2207 | 16-Bit, 80Msps/105Msps 3.3V ADCs | 725mW/900mW, 77.9dB SNR, 100dB SFDR, CMOS Outputs, 7mm × 7mm QFN-48 |
| ITC2209 | LTC2208 | 16-Bit, 130Msps 3.3V ADC | 1250mW, 77.7dB SNR, 100dB SFDR, LVDS Outputs, 9mm × 9mm QFN-64 |
| 1G-2216/LTC2216/ | LTC2208-14 | 14-Bit, 130Msps 3.3V ADC | 1320mW, 77.1dB SNR, 98dB SFDR, LVDS Outputs, 9mm × 9mm QFN-64 |
| 1G-2216/LTC2216/ | LTC2209 | 16-Bit, 160Msps 3.3V ADC | 1450mW, 77.1dB SNR, 100dB SFDR, LVDS Outputs, 9mm × 9mm QFN-64 |
| LTC2224-12 | | | |
| LTC2258-14 LTC2258-14/LTC2260-14/ LTC2261-14 LTC2261-12 LTC261-12 LTC2261-12 LTC261-12 LTC2261-12 LTC261-12 | | | |
| ITC2261-14 | | | |
| 6mm x 6mm QFN-36 TC2263-14/LTC2264-14 LTC2265-14 LTC2265-14 LTC2265-14 LTC2265-14 LTC2265-12 LTC2265-14 LTC2265-14 LTC2265-12 LTC2265-12 LTC2266-12/LTC2267-14 LTC2268-14 LTC2266-12/LTC2267-14 LTC2268-14 LTC2266-12/LTC2267-12 LTC2268-14 LTC2266-12/LTC2267-12 LTC2268-12 LTC2266-12/LTC2267-12 LTC2268-12 LTC2266-12/LTC2267-12 LTC2268-12 LTC258-12 LTC2268-12 LTC2268-12 LTC2268-12 LTC2268-12 LTC2268-12 LTC2268-12 LTC268-12 LTC26 | | 14-Bit, 80Msps/105Msps/125Msps 1.8V ADCs, Ultralow Power | 89mW/106mW/127mW, 73.4dB SNR, 85dB SFDR, DDR LVDS/DDR CMOS/CMOS Outputs, 6mm × 6mm QFN-36 |
| LTC2265-14 1.8V Dual ADCs, Ultralow Power 6mm v 6mm QFN-36 LTC2263-12/LTC2264-12/ LTC2265-12 1.8V Dual ADCs, Ultralow Power 6mm v 6mm QFN-36 LTC2265-12 1.8V Dual ADCs, Ultralow Power 6mm v 6mm QFN-36 LTC2266-14/LTC2267-14/ LTC2268-14 1.8V Bual ADCs, Ultralow Power 6mm v 6mv v 6mm v 6mm v 6mm v 6mm v 6mm v 6mv v 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 | LTC2262-14 | 14-Bit, 150Msps 1.8V ADC, Ultralow Power | |
| LTC2265-121.8V Dual ADCs, Ultralow Power6mm × 6mm QFN-36LTC2266-14/LTC2267-14/ LTC2268-1414-Bit, 80Msps/105Msps/125Msps 1.8V Dual ADCs, Ultralow Power216mW/250mW/293mW, 73.4dB SNR, 85dB SFDR, Serial LVDS Outputs, 6mm × 6mm QFN-36LTC2268-1212-Bit, 80Msps/105Msps/125Msps 1.8V Dual ADCs, Ultralow Power216mW/250mW/293mW, 70.5dB SNR, 85dB SFDR, Serial LVDS Outputs, 6mm × 6mm QFN-36LTC2288/LTC228514-Bit, 105Msps/125Msps 3V Dual ADCs540mW/790mW, 72.4dB SNR, 88dB SFDR, CMOS Outputs, 9mm × 9mm QFN-64LTC2295/LTC2296/ LTC2298/LTC229914-Bit, 10Msps/25Msps/40Msps 3V Dual | | | |
| LTC2268-14 LTC2266-12/LTC2267-12/LTC2267-12 LTC2268-12 LTC2268-12 LTC2268-12 LTC2268-12 LTC2268-12 LTC2268-12 LTC2268-12 LTC2268-12 LTC2284/LTC2285 LTC2298/LTC2296/ LTC2299/LTC2296/ LTC2299/LTC2299/LTC2299 LTC2298/LTC2299 LTC25517 40MHz to 900MHz Direct Conversion Quadrature Demodulator LTC5517 400MHz to 3.7GHz High Linearity Downconverting Mixer LTC5557 400MHz to 3.8GHz High Linearity Downconverting Mixer LTC5557 400MHz to 2.7GHz Direct Conversion Quadrature Demodulator LTC5575 800MHz to 2.7GHz Direct Conversion Quadrature Demodulator LTC5575 800MHz, 31dB Range, Analog-Controlled Variable Gain Amplifier LTC6416 800MHz, 31dB Range, Analog-Controlled Variable Gain Amplifier LTC6420-20 1.8GHz Dual Low Noise, Low Distortion Differential ADC Drivers for 300MHz IF LTC66421-20 1.3GHz Dual Low Noise, Low Distortion Differential ADC Drivers LTC6605-7/LTC6605-10/ Dual Matched 7MHz/10MHz/14MHz Filters LTC6420-20 Dual Matched 7MHz/10MHz/14MHz Filters LTC6605-7/LTC6605-10/ Dual Matched 7MHz/10MHz/14MHz Filters LTC6605-7/LTC6605-10/ Dual Matched 7MHz/10MHz/14MHz Filters LTC6605-7/LTC6605-10/ Dual Matched 7MHz/10MHz/14MHz Filters LTC6420-20 Dual Matched 7MHz/10MHz/14MHz Filters LTC6605-7/LTC6605-10/ Dual Matched 7MHz/10MHz/14MHz Filters LTC6420-20 Dual Matched 7MHz/10MHz/14MHz Filters LTC6605-7/LTC6605-10/ Dual Matched 7MHz/10MHz/14MHz Filters LTC6420-20 Dual Matched 7MHz/10MHz/14MHz Filters | | | |
| LTC2268-12 LTC2286/LTC2295 LTC2296/LTC2296/ LTC2296/LTC2296/ LTC2297 LTC2296/LTC2296/ LTC2297 LTC2298/LTC2296/ LTC2298/LTC2297 LTC2298/LTC2298 LTC2298/LTC2299 14-Bit, 10Msps/25Msps/40Msps 3V Dual ADCs ADCs ADCs ADCs ADCs ADCs ADCs ADCs | | | |
| LTC2295/LTC2296/ LTC229714-Bit, 10Msps/25Msps/40Msps 3V Dual ADCs120mW/150mW/235mW, 74.4dB SNR, 90dB SFDR, CMOS Outputs, 9mm × 9mm QFN-64LTC2298/LTC229914-Bit, 65Msps/80Msps 3V Dual ADCs400mW/444mW, 74.3dB/73.0dB SNR, 90dB SFDR, CMOS Outputs, 9mm × 9mm QFN-RF Mixers/Demodulators40MHz to 900MHz Direct Conversion Quadrature DemodulatorHigh IIP3: 21dBm at 800MHz, Integrated LO Quadrature GeneratorLTC5517400MHz to 3.7GHz High Linearity Downconverting Mixer24.5dBm IIP3 at 900MHz, 23.5dBm IIP3 at 3.5GHz, NF = 12.5dB, 50Ω Single-Ended RF and LO PortsLTC5557400MHz to 3.8GHz High Linearity Downconverting Mixer23.7dBm IIP3 at 2.6GHz, 23.5dBm IIP3 at 3.5GHz, NF = 13.2dB, 3.3V Supply Operation, Integrated TransformerLTC5575800MHz to 2.7GHz Direct Conversion Quadrature DemodulatorHigh IIP3: 28dBm at 900MHz, Integrated LO Quadrature Generator, Integrated Rf and LO TransformerAmplifiers/Filters800MHz, 31dB Range, Analog-Controlled Variable Gain AmplifierContinuously Adjustable Gain Control, 35dBm OIP3 at 240MHz, 10dB Noise Figure, 4mm × 4mm QFN-24LTC6420-201.8GHz Dual Low Noise, Low Distortion Differential ADC Drivers for 300MHz IFContinuously Adjustable Gain Control, 35dBm OIP3 at 240MHz, 10dB Noise Fixed Gain 10V/V, 1nV/\Hz Total Input Noise, 80mA Supply Current per Amplifier, 3mm × 4mm QFN-20LTC66421-201.3GHz Dual Low Noise, Low Distortion Differential ADC DriversFixed Gain 10V/V, 1nV/\Hz Total Input Noise, 40mA Supply Current per Amplifier, 3mm × 4mm QFN-20LTC6605-10/Dual Matched 7MHz/10MHz/14MHz FiltersDual Matched 2nd Order Lowpass Filters with Differential Drivers, | | 1.8V Dual ADCs, Ultralow Power | |
| LTC2297ADCsQFN-64LTC2298/LTC229914-Bit, 65Msps/80Msps 3V Dual ADCs400mW/444mW, 74.3dB/73.0dB SNR, 90dB SFDR, CMOS Outputs, 9mm × 9mm QFN-RF Mixers/DemodulatorsLTC551740MHz to 900MHz Direct Conversion Quadrature DemodulatorHigh IIP3: 21dBm at 800MHz, Integrated LO Quadrature GeneratorLTC5527400MHz to 3.7GHz High Linearity Downconverting Mixer24.5dBm IIP3 at 900MHz, 23.5dBm IIP3 at 3.5GHz, NF = 12.5dB, 50Ω Single-Ended RF and LO PortsLTC5557400MHz to 3.8GHz High Linearity Downconverting Mixer23.7dBm IIP3 at 2.6GHz, 23.5dBm IIP3 at 3.5GHz, NF = 13.2dB, 3.3V Supply Operation, Integrated TransformerLTC5575800MHz to 2.7GHz Direct Conversion Quadrature DemodulatorHigh IIP3: 28dBm at 900MHz, Integrated LO Quadrature Generator, Integrated RI and LO TransformerAmplifiers/FiltersContinuously Adjustable Gain Control, 35dBm OIP3 at 240MHz, 10dB Noise Figure, 4mm × 4mm QFN-24LTC6420-201.8GHz Dual Low Noise, Low Distortion Differential ADC Drivers for 300MHz IF Sixed Gain 10V/V, 1nV/√Hz Total Input Noise, 80mA Supply Current per Amplifier, 3mm × 4mm QFN-20LTC6421-201.3GHz Dual Low Noise, Low Distortion Differential ADC DriversFixed Gain 10V/V, 1nV/√Hz Total Input Noise, 40mA Supply Current per Amplifier, 3mm × 4mm QFN-20LTC6605-10/Dual Matched 7MHz/10MHz/14MHz FiltersDual Matched 2nd Order Lowpass Filters with Differential Drivers, | LTC2284/LTC2285 | 14-Bit, 105Msps/125Msps 3V Dual ADCs | 540mW/790mW, 72.4dB SNR, 88dB SFDR, CMOS Outputs, 9mm × 9mm QFN-64 |
| RF Mixers/DemodulatorsLTC551740MHz to 900MHz Direct Conversion Quadrature DemodulatorHigh IIP3: 21dBm at 800MHz, Integrated LO Quadrature GeneratorLTC5527400MHz to 3.7GHz High Linearity Downconverting Mixer24.5dBm IIP3 at 900MHz, 23.5dBm IIP3 at 3.5GHz, NF = 12.5dB, 50Ω Single-Ended RF and LO PortsLTC5557400MHz to 3.8GHz High Linearity Downconverting Mixer23.7dBm IIP3 at 2.6GHz, 23.5dBm IIP3 at 3.5GHz, NF = 13.2dB, 3.3V Supply Operation, Integrated TransformerLTC5575800MHz to 2.7GHz Direct Conversion Quadrature DemodulatorHigh IIP3: 28dBm at 900MHz, Integrated LO Quadrature Generator, Integrated Rf and LO TransformerAmplifiers/FiltersLTC6416800MHz, 31dB Range, Analog-Controlled Variable Gain AmplifierContinuously Adjustable Gain Control, 35dBm OIP3 at 240MHz, 10dB Noise Figure, 4mm × 4mm QFN-24LTC6420-201.8GHz Dual Low Noise, Low Distortion Differential ADC Drivers for 300MHz IFFixed Gain 10V/V, 1nV/√Hz Total Input Noise, 80mA Supply Current per Amplifier, 3mm × 4mm QFN-20LTC6421-201.3GHz Dual Low Noise, Low Distortion Differential ADC DriversFixed Gain 10V/V, 1nV/√Hz Total Input Noise, 40mA Supply Current per Amplifier, 3mm × 4mm QFN-20LTC6605-7/ LTC6605-10/Dual Matched 7MHz/10MHz/14MHz FiltersDual Matched 2nd Order Lowpass Filters with Differential Drivers, | LTC2295/LTC2296/ LTC2297 | | 120mW/150mW/235mW, 74.4dB SNR, 90dB SFDR, CMOS Outputs, 9mm × 9mm QFN-64 |
| LTC551740MHz to 900MHz Direct Conversion Quadrature DemodulatorHigh IIP3: 21dBm at 800MHz, Integrated LO Quadrature GeneratorLTC5527400MHz to 3.7GHz High Linearity Downconverting Mixer24.5dBm IIP3 at 900MHz, 23.5dBm IIP3 at 3.5GHz, NF = 12.5dB, 50Ω Single-Ended RF and LO PortsLTC5557400MHz to 3.8GHz High Linearity | LTC2298/LTC2299 | 14-Bit, 65Msps/80Msps 3V Dual ADCs | 400mW/444mW, 74.3dB/73.0dB SNR, 90dB SFDR, CMOS Outputs, 9mm × 9mm QFN-64 |
| Quadrature Demodulator 24.5dBm IIP3 at 900MHz, 23.5dBm IIP3 at 3.5GHz, NF = 12.5dB, 50Ω Single-Ended RF and LO Ports | RF Mixers/Demodulators | | |
| Downconverting Mixer LTC5557 400MHz to 3.8GHz High Linearity Downconverting Mixer LTC5575 800MHz to 2.7GHz Direct Conversion Quadrature Demodulator High IIP3: 28dBm at 900MHz, Integrated LO Quadrature Generator, Integrated Rf and LO Transformer High IIP3: 28dBm at 900MHz, Integrated LO Quadrature Generator, Integrated Rf and LO Transformer Amplifiers/Filters LTC6416 800MHz, 31dB Range, Analog-Controlled Variable Gain Amplifier LTC6420-20 1.8GHz Dual Low Noise, Low Distortion Differential ADC Drivers for 300MHz IF LTC6421-20 1.3GHz Dual Low Noise, Low Distortion Differential ADC Drivers Tixed Gain 10V/V, 1nV/√Hz Total Input Noise, 80mA Supply Current per Amplifier, 3mm × 4mm QFN-20 LTC6605-7/ LTC6605-10/ Dual Matched 7MHz/10MHz/14MHz Filters Dual Matched 2nd Order Lowpass Filters with Differential Drivers, | LTC5517 | | High IIP3: 21dBm at 800MHz, Integrated LO Quadrature Generator |
| Downconverting Mixer UTC5575 B00MHz to 2.7GHz Direct Conversion Quadrature Demodulator High IIP3: 28dBm at 900MHz, Integrated LO Quadrature Generator, Integrated Rf and LO Transformer High IIP3: 28dBm at 900MHz, Integrated LO Quadrature Generator, Integrated Rf and LO Transformer Mmplifiers/Filters UTC6416 B00MHz, 31dB Range, Analog-Controlled Variable Gain Amplifier UTC6420-20 1.8GHz Dual Low Noise, Low Distortion Differential ADC Drivers for 300MHz IF UTC6421-20 1.3GHz Dual Low Noise, Low Distortion Differential ADC Drivers UTC6605-7/ LTC6605-10/ Dual Matched 7MHz/10MHz/14MHz Filters Dual Matched 2nd Order Lowpass Filters with Differential Drivers, | LTC5527 | 400MHz to 3.7GHz High Linearity Downconverting Mixer | 24.5dBm IIP3 at 900MHz, 23.5dBm IIP3 at 3.5GHz, NF = 12.5dB, 50Ω Single-Ended RF and LO Ports |
| Quadrature Demodulator Amplifiers/Filters | LTC5557 | 400MHz to 3.8GHz High Linearity Downconverting Mixer | 23.7dBm IIP3 at 2.6GHz, 23.5dBm IIP3 at 3.5GHz, NF = 13.2dB, 3.3V Supply Operation, Integrated Transformer |
| LTC6416 800MHz, 31dB Range, Analog-Controlled Variable Gain Amplifier Continuously Adjustable Gain Control, 35dBm OIP3 at 240MHz, 10dB Noise Figure, 4mm × 4mm QFN-24 LTC6420-20 1.8GHz Dual Low Noise, Low Distortion Differential ADC Drivers for 300MHz IF LTC6421-20 1.3GHz Dual Low Noise, Low Distortion Differential ADC Drivers Tixed Gain 10V/V, 1nV/√Hz Total Input Noise, 80mA Supply Current per Amplifier, 3mm × 4mm QFN-20 Fixed Gain 10V/V, 1nV/√Hz Total Input Noise, 40mA Supply Current per Amplifier, 3mm × 4mm QFN-20 LTC6605-7/ LTC6605-10/ Dual Matched 7MHz/10MHz/14MHz Filters Dual Matched 2nd Order Lowpass Filters with Differential Drivers, | LTC5575 | | High IIP3: 28dBm at 900MHz, Integrated LO Quadrature Generator, Integrated RF and LO Transformer |
| Variable Gain AmplifierFigure, 4mm × 4mm QFN-24LTC6420-201.8GHz Dual Low Noise, Low Distortion Differential ADC Drivers for 300MHz IFFixed Gain 10V/V, 1nV/√Hz Total Input Noise, 80mA Supply Current per Amplifier, 3mm × 4mm QFN-20LTC6421-201.3GHz Dual Low Noise, Low Distortion Differential ADC DriversFixed Gain 10V/V, 1nV/√Hz Total Input Noise, 40mA Supply Current per Amplifier, 3mm × 4mm QFN-20LTC6605-7/ LTC6605-10/Dual Matched 7MHz/10MHz/14MHz FiltersDual Matched 2nd Order Lowpass Filters with Differential Drivers, | Amplifiers/Filters | | |
| Differential ADC Drivers for 300MHz IF Smm × 4mm QFN-20 LTC6421-20 1.3GHz Dual Low Noise, Low Distortion Differential ADC Drivers Fixed Gain 10V/V, 1nV/√Hz Total Input Noise, 40mA Supply Current per Amplifier, 3mm × 4mm QFN-20 LTC6605-7/ LTC6605-10/ Dual Matched 7MHz/10MHz/14MHz Filters Dual Matched 2nd Order Lowpass Filters with Differential Drivers, | LTC6416 | 800MHz, 31dB Range, Analog-Controlled Variable Gain Amplifier | |
| Differential ADC Drivers 3mm × 4mm QFN-20 LTC6605-7/ LTC6605-10/ Dual Matched 7MHz/10MHz/14MHz Filters Dual Matched 2nd Order Lowpass Filters with Differential Drivers, | LTC6420-20 | | Fixed Gain 10V/V, 1nV/ $\sqrt{\text{Hz}}$ Total Input Noise, 80mA Supply Current per Amplifier, 3mm \times 4mm QFN-20 |
| LTC6605-7/ LTC6605-10/ Dual Matched 7MHz/10MHz/14MHz Filters Dual Matched 2nd Order Lowpass Filters with Differential Drivers, | LTC6421-20 | | Fixed Gain 10V/V, 1nV/√Hz Total Input Noise, 40mA Supply Current per Amplifier, 3mm × 4mm QFN-20 |
| LI OUOUU-14 WILLI ADO DITVETS FILI-FI OGTAILI II AUTU DE IV-22 | LTC6605-7/ LTC6605-10/ LTC6605-14 | | Dual Matched 2nd Order Lowpass Filters with Differential Drivers, Pin-Programmable Gain, 6mm × 3mm DFN-22 |

